



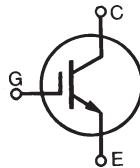
Polar™ High Speed  
**IGBT**  
 for PDP Applications

**IXGQ170N30PB**

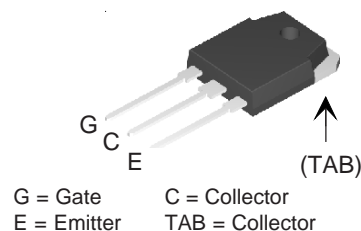
$$V_{CES} = 300 \text{ V}$$

$$I_{CP} = 360 \text{ A}$$

$$V_{CE(sat)} \leq 1.70 \text{ V}$$



Symbol	Test Conditions	Maximum Ratings	
$V_{CES}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$	300	V
$V_{GEM}$		$\pm 30$	V
$I_{C25}$	$T_C = 25^\circ\text{C}$ , IGBT chip capability	170	A
$I_{CP}$	$T_J \leq 150^\circ\text{C}$ , $t_p < 10 \mu\text{s}$	360	A
$I_{C(RMS)}$	Lead current limit	75	A
<b>SSOA</b> <b>(RBSOA)</b>	$V_{GE} = 15 \text{ V}$ , $T_{VJ} = 150^\circ\text{C}$ , $R_G = 20 \Omega$ Clamped inductive load, $V_{CE} < 300 \text{ V}$	$I_{CM} = 170$	A
$P_C$	$T_C = 25^\circ\text{C}$	330	W
$T_J$		-55 ... +150	$^\circ\text{C}$
$T_{JM}$		150	$^\circ\text{C}$
$T_{stg}$		-55 ... +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s	300	$^\circ\text{C}$
$T_{SOLD}$	Maximum plastic body temperature for 10 s.	260	$^\circ\text{C}$
$M_d$	Mounting torque	1.13/10	Nm/lb.in.
<b>Weight</b>		5.5	g

**TO-3P**

**Features**

- International standard package
- Low  $V_{CE(sat)}$ 
  - for minimum on-state conduction losses
- MOS Gate turn-on
  - drive simplicity

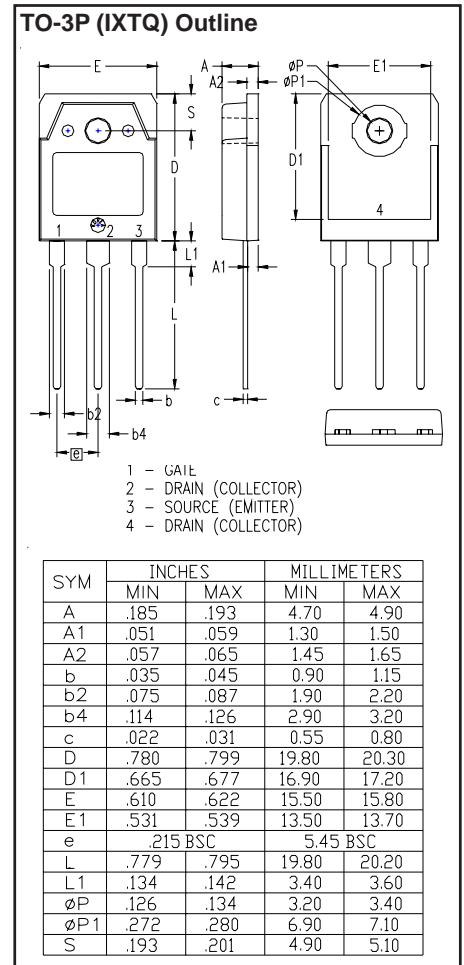
**Applications**

- PDP Screen Drivers

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
$V_{GE(th)}$	$I_C = 1 \text{ mA}$ , $V_{CE} = V_{GE}$	3.0		5.0 V
$I_{CES}$	$V_{CE} = 300 \text{ V}$			1 $\mu\text{A}$
	$V_{GE} = 0 \text{ V}$ , $T_J = 125^\circ\text{C}$			200 $\mu\text{A}$
$I_{GES}$	$V_{CE} = 0 \text{ V}$ , $V_{GE} = \pm 20 \text{ V}$			$\pm 100 \text{ nA}$
$V_{CE(sat)}$	$V_{GE} = 15 \text{ V}$ , Note 1	$I_C = 85 \text{ A}$	1.32	1.70 V
		$T_J = 125^\circ\text{C}$	1.36	V
		$I_C = 170 \text{ A}$	1.73	V
		$T_J = 125^\circ\text{C}$	1.89	V

Symbol ( $T_J = 25^\circ\text{C}$ unless otherwise specified)	Test Conditions	Characteristic Values		
		Min.	Typ.	Max.
$g_{fs}$	$I_C = 85\text{ A}, V_{CE} = 10\text{ V}$	50	80	S
$C_{ies}$ $C_{oes}$ $C_{res}$	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$		5140	pF
			315	pF
			83	pF
$Q_g$ $Q_{ge}$ $Q_{gc}$	$I_C = 85\text{ A}, V_{GE} = 15\text{ V}, V_{CE} = 0.5 V_{CES}$		143	nC
			26	nC
			60	nC
$t_{d(on)}$ $t_{ri}$ $t_{d(off)}$ $t_{fi}$	Resistive load, $T_J = 25^\circ\text{C}$ $I_C = 85\text{ A}, V_{GE} = 15\text{ V}$ $V_{CE} = 240\text{ V}, R_G = 2.4\ \Omega$		24	ns
			71	ns
			100	ns
			82	ns
$t_{d(on)}$ $t_{ri}$ $t_{d(off)}$ $t_{fi}$	Resistive load, $T_J = 125^\circ\text{C}$ $I_C = 85\text{ A}, V_{GE} = 15\text{ V}$ $V_{CE} = 240\text{ V}, R_G = 2.4\ \Omega$		22	ns
			81	ns
			102	ns
			157	ns
$R_{thJC}$ $R_{thCS}$			0.375	K/W
		0.21		K/W

Note 1: Pulse test,  $t \leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$

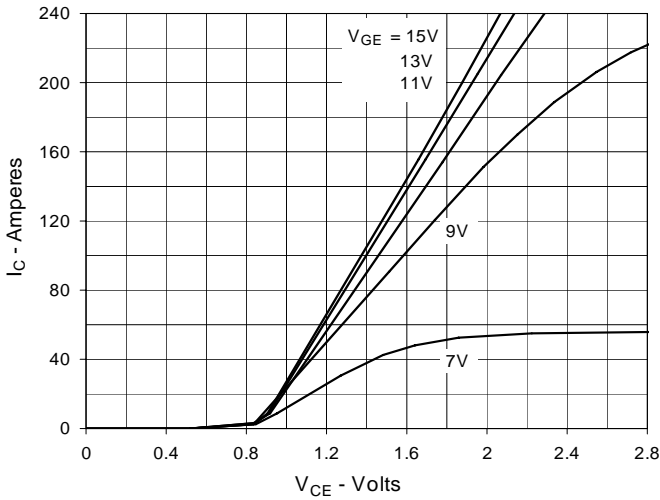
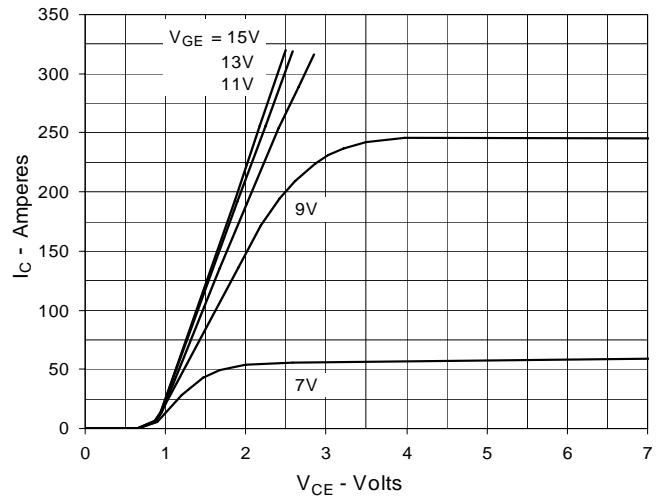
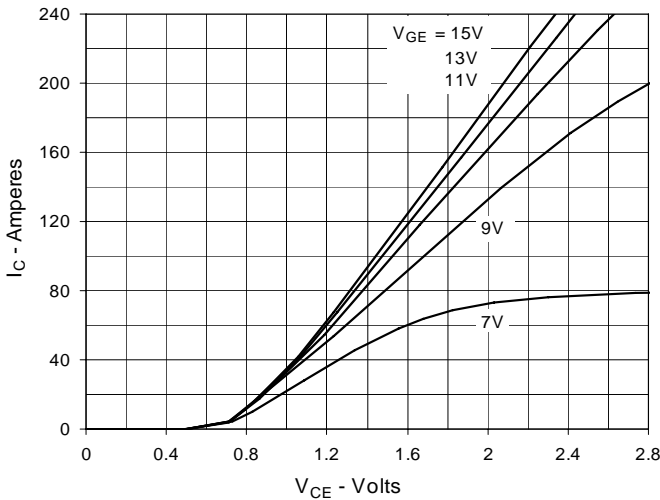
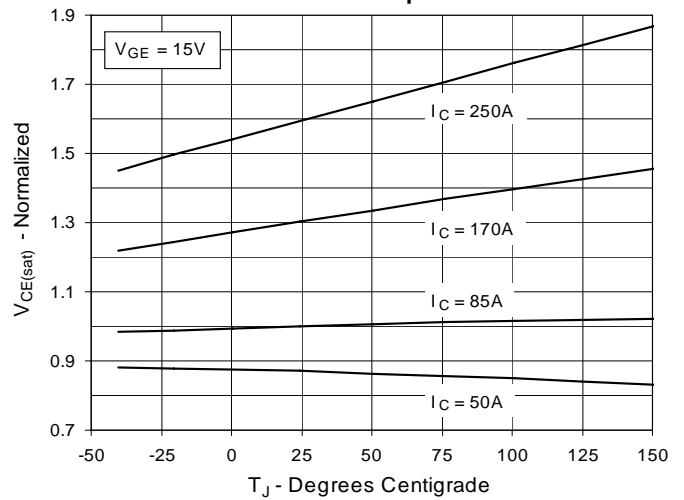
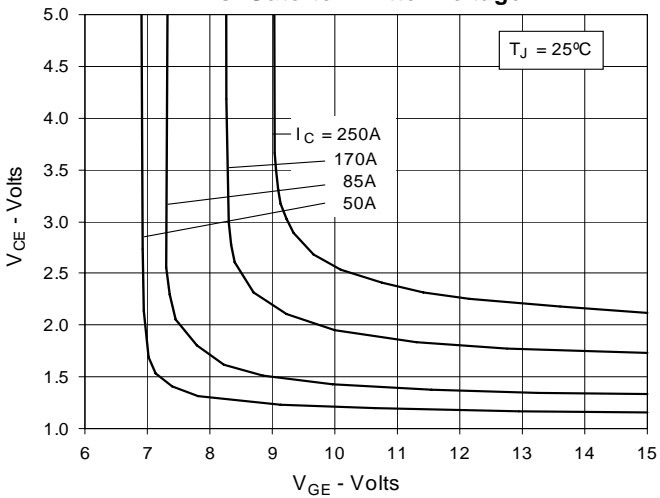
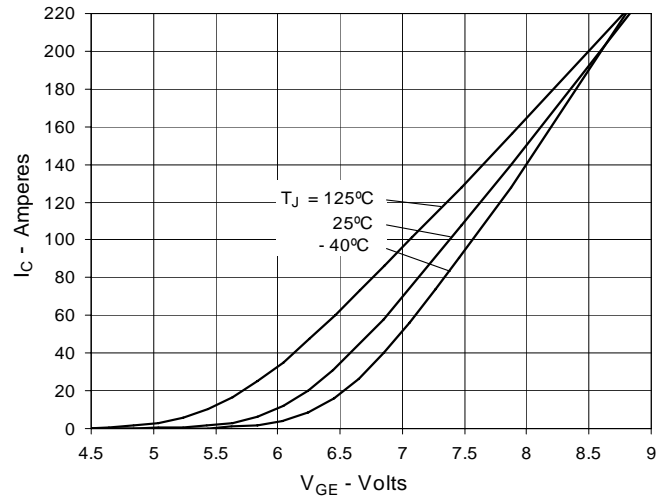


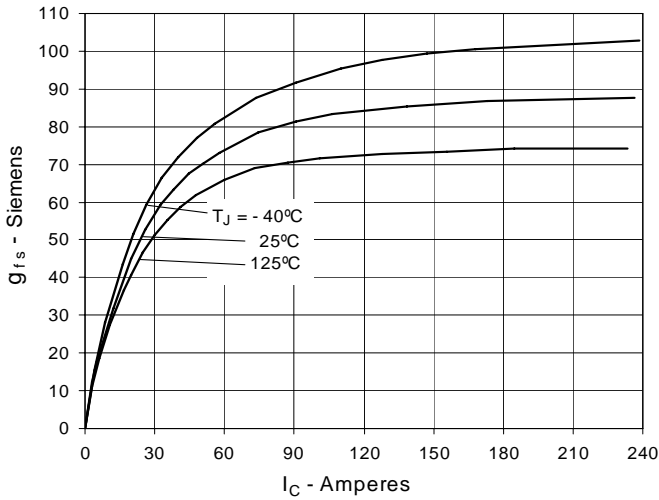
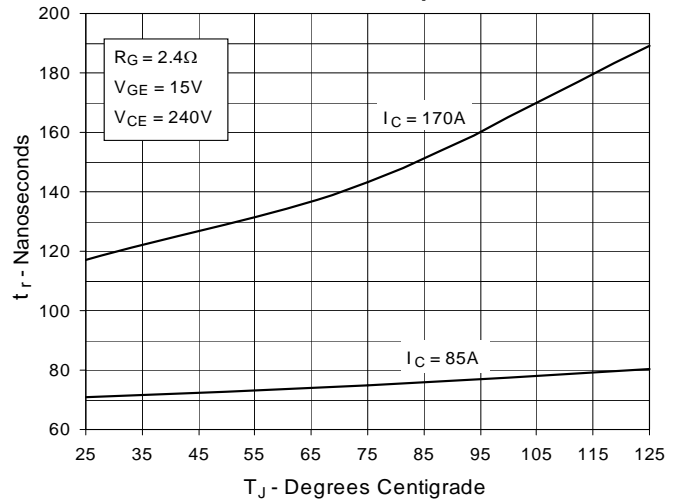
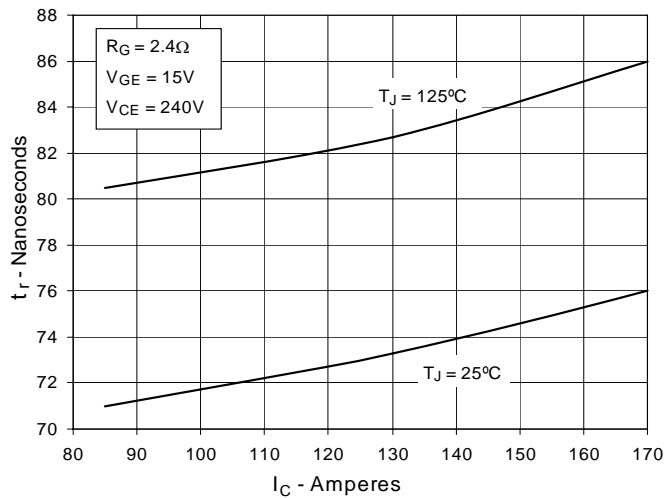
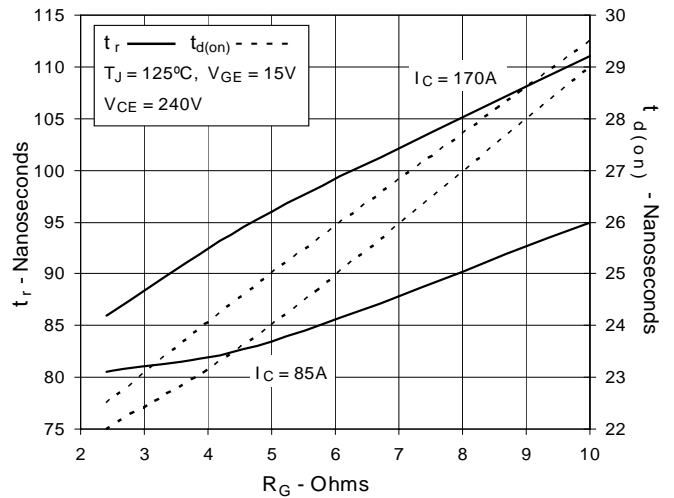
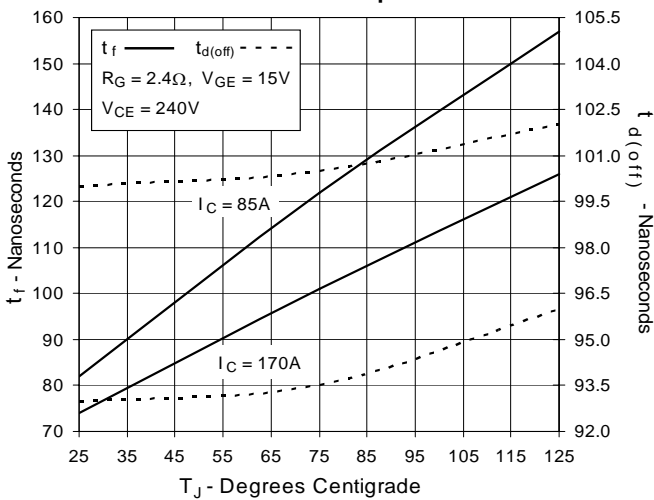
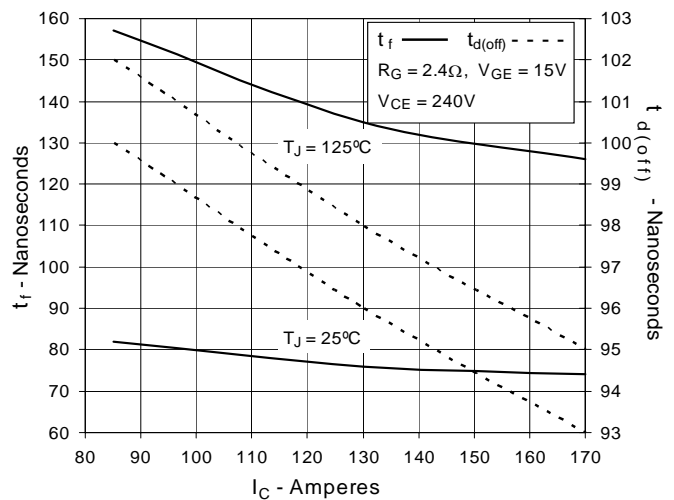
**PRELIMINARY TECHNICAL INFORMATION**

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

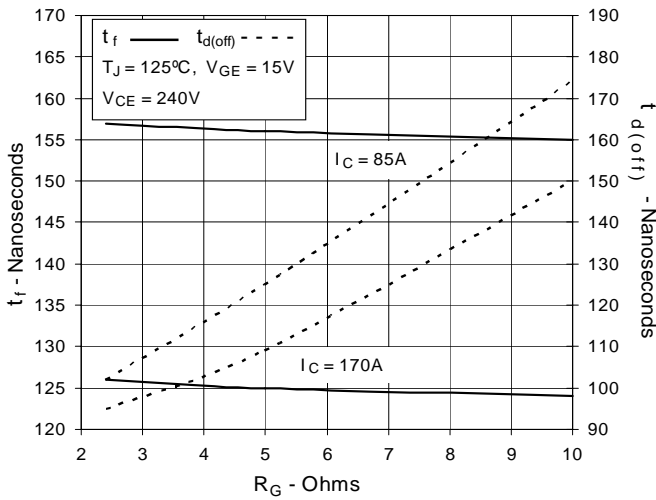
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IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585  
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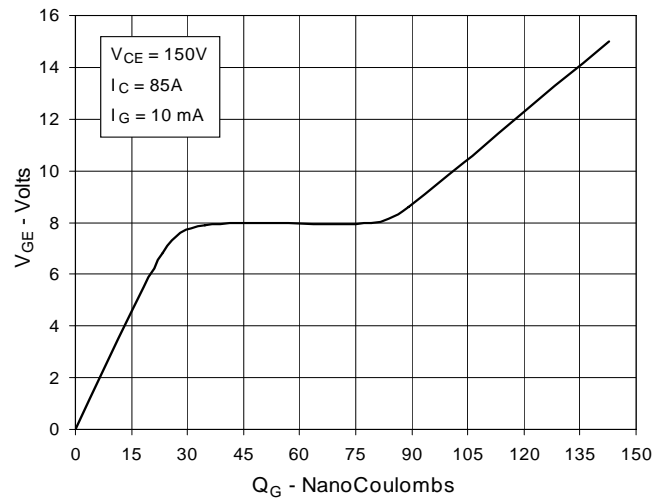
**Fig. 1. Output Characteristics @ 25°C**

**Fig. 2. Extended Output Characteristics @ 25°C**

**Fig. 3. Output Characteristics @ 125°C**

**Fig. 4. Dependence of Vce(sat) on Junction Temperature**

**Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage**

**Fig. 6. Input Admittance**


**Fig. 7. Transconductance**

**Fig. 8. Resistive Turn-on Rise Time vs. Junction Temperature**

**Fig. 9. Resistive Turn-on Rise Time vs. Collector Current**

**Fig. 10. Resistive Turn-on Switching Times vs. Gate Resistance**

**Fig. 11. Resistive Turn-off Switching Times vs. Junction Temperature**

**Fig. 12. Resistive Turn-off Switching Times vs. Collector Current**


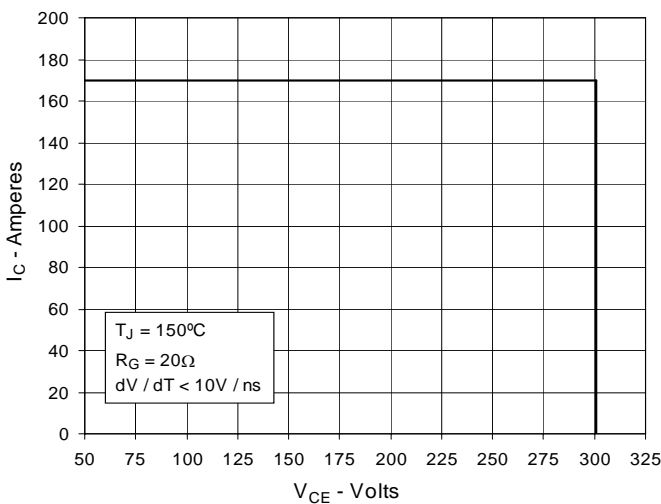
**Fig. 13. Resistive Turn-off Switching Times vs. Gate Resistance**



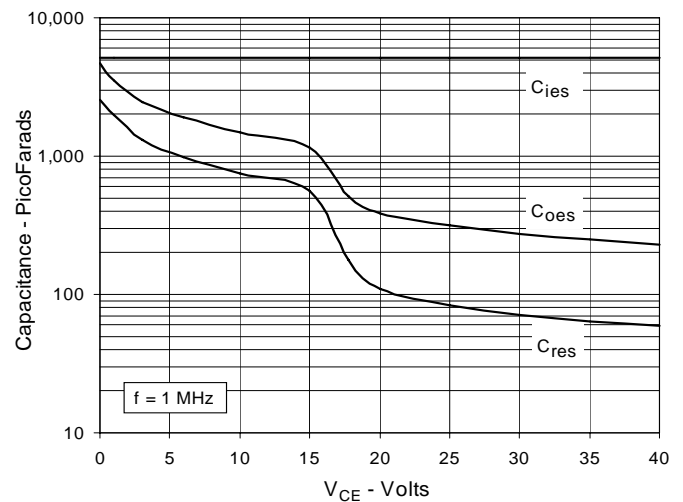
**Fig. 14. Gate Charge**



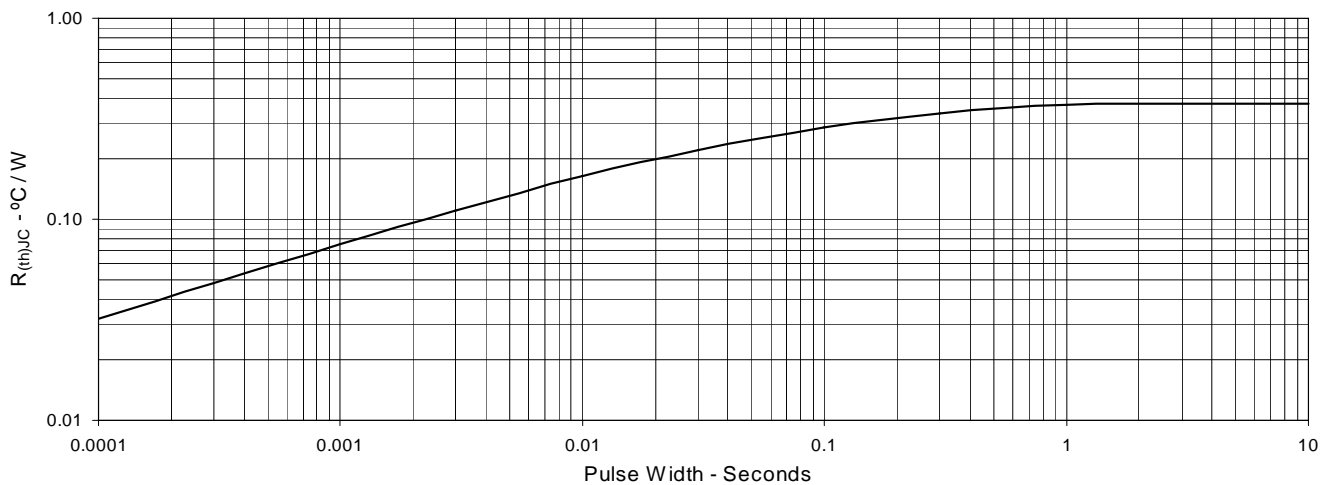
**Fig. 15. Reverse-Bias Safe Operating Area**



**Fig. 16. Capacitance**



**Fig. 17. Maximum Transient Thermal Resistance**



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